## **<u>MOSFET</u> – Power, Single, N-Channel** 40 V, 2.1 mΩ, 160 A

#### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	40	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Cur-		$T_{C} = 25^{\circ}C$	I <sub>D</sub>	160	А
rent $R_{\theta JC}$ (Notes 1 & 3)	Steady	$T_{C} = 100^{\circ}C$		120	
Power Dissipation $R_{\theta JC}$	State	$T_{C} = 25^{\circ}C$	PD	120	W
(Note 1)		$T_{C} = 100^{\circ}C$		59	
Continuous Drain	Steady State	$T_A = 25^{\circ}C$	Ι <sub>D</sub>	33	А
Current R <sub>θJA</sub> (Notes 1, 2 & 3)		T <sub>A</sub> = 100°C		23	
Power Dissipation $R_{\theta JA}$		$T_A = 25^{\circ}C$	PD	4.7	W
(Notes 1 & 2)		T <sub>A</sub> = 100°C		2.4	
Pulsed Drain Current	$T_A = 25^{\circ}C$ , $t_p = 10 \ \mu s$		I <sub>DM</sub>	900	А
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to 175	°C
Source Current (Body Diode)			I <sub>S</sub>	130	А
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 25 A)			E <sub>AS</sub>	420	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

#### MAXIMUM RATINGS (T<sub>.1</sub> = 25°C unless otherwise noted)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{\theta JC}$	1.3	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	32	

 The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
 Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

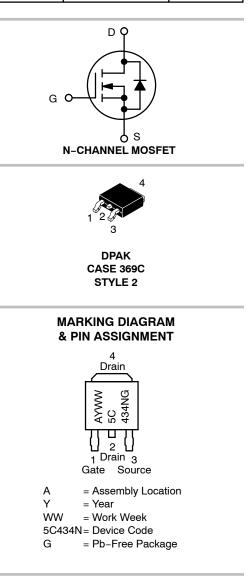
 Surface-modified on the board using a 050 minit, 2 02, 60 pad.
 Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



## **ON Semiconductor®**

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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
40 V	2.1 mΩ @ 10 V	160 A



#### **ORDERING INFORMATION**

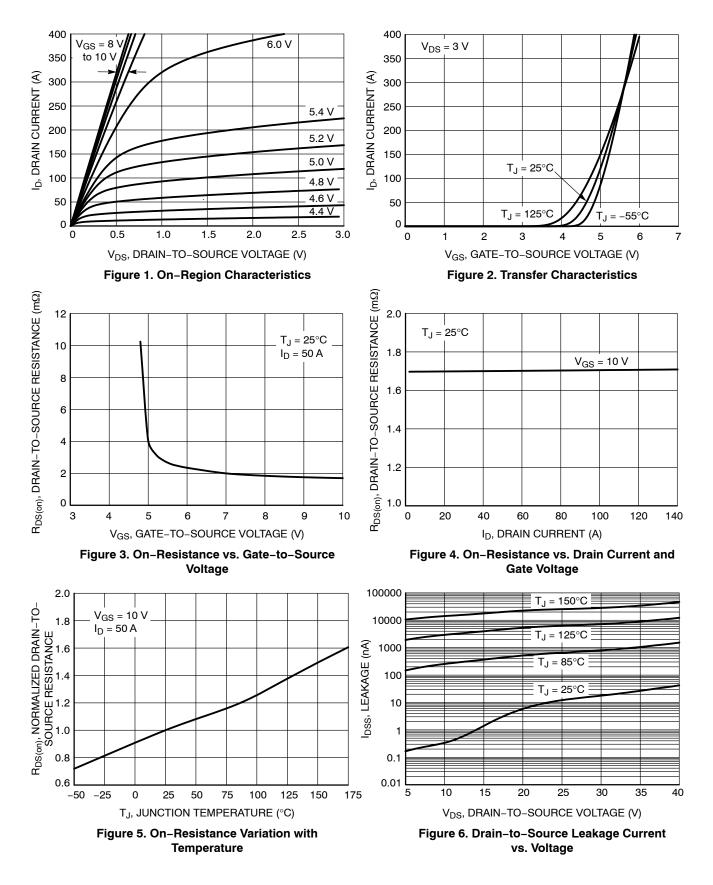
See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise noted)

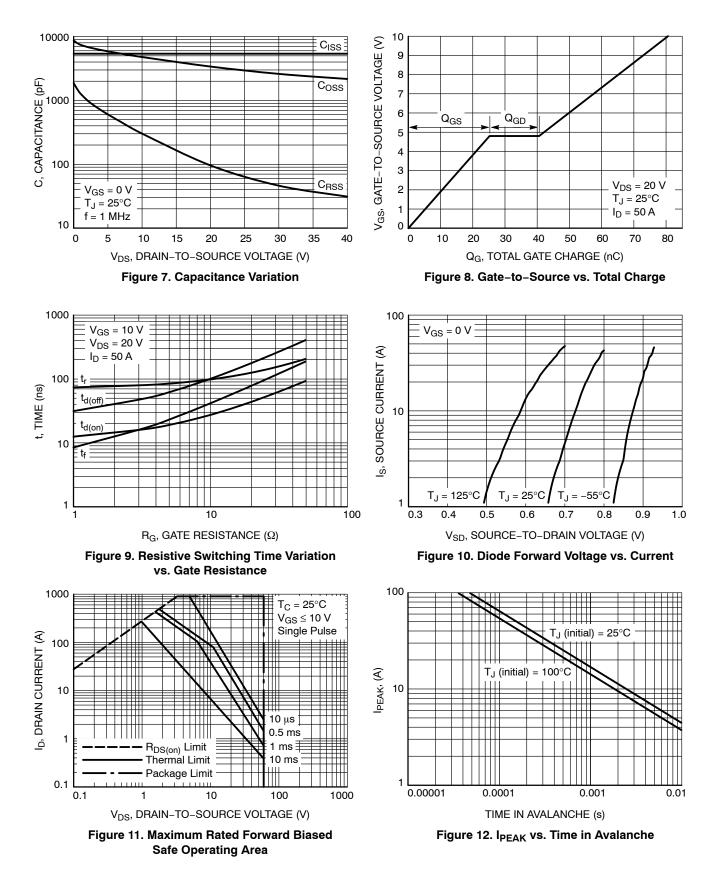
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				18		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	•GS = 0 •,	T <sub>J</sub> = 25°C			10	μA
			$T_J = 125^{\circ}C$			250	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{G}$	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μA	2.0		4.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				7.9		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>E</sub>	<sub>0</sub> = 50 A		1.7	2.1	mΩ
Forward Transconductance	<b>9</b> FS	$V_{DS}$ = 3 V, $I_{D}$	= 50 A		155		S
CHARGES, CAPACITANCES AND GATE RE	SISTANCES						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 25 V			5400		pF
Output Capacitance	C <sub>oss</sub>				3000		
Reverse Transfer Capacitance	C <sub>rss</sub>				71		
Total Gate Charge	Q <sub>G(TOT)</sub>				80.6		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				15.2		
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = 10 V, V <sub>D</sub> I <sub>D</sub> = 50	<sub>S</sub> = 20 V, A		25.2		1
Gate-to-Drain Charge	Q <sub>GD</sub>	ID = 50 A			15.4		
Plateau Voltage	V <sub>GP</sub>				4.8		V
SWITCHING CHARACTERISTICS (Note 5)					-		
Turn-On Delay Time	t <sub>d(on)</sub>				15		ns
Rise Time	t <sub>r</sub>	$V_{CR} = 10 V_{c} V_{D}$	$h_{0} = 20 V_{0}$		78		
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 20 V, $I_{D}$ = 50 A, $R_{G}$ = 2.5 $\Omega$			43		
Fall Time	t <sub>f</sub>				14		
DRAIN-SOURCE DIODE CHARACTERISTIC	S				•		
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V,   T_{J} = 25^{\circ}C \\ I_{S} = 50 A   T_{J} = 125^{\circ}C$	$T_J = 25^{\circ}C$		0.8	1.2	V
			T <sub>J</sub> = 125°C		0.7		1
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dls/dt = 100 A/μs, I <sub>S</sub> = 50 A			73		ns
Charge Time	ta				36		1
Discharge Time	tb				37		1
Reverse Recovery Charge	Q <sub>RR</sub>				120		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: Pulse Width  $\leq$  300 µs, Duty Cycle  $\leq$  2%. 5. Switching characteristics are independent of operating junction temperatures. ditions, unless otherwise noted. Prod

#### **TYPICAL CHARACTERISTICS**



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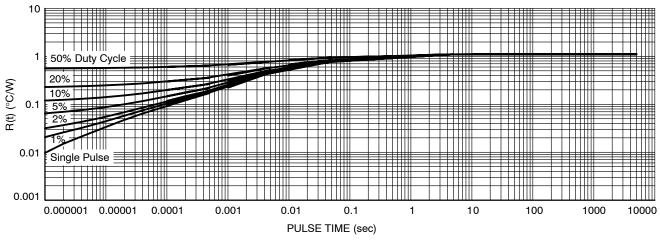


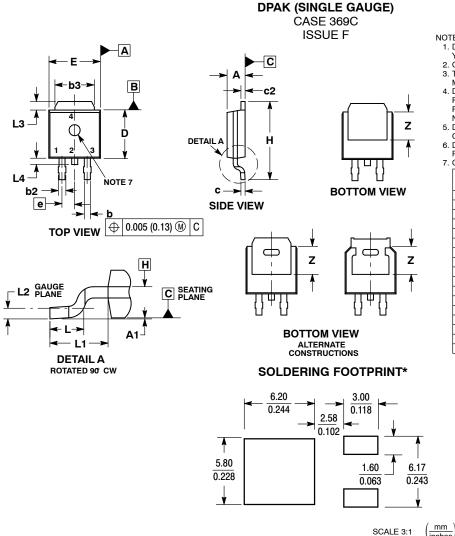
Figure 13. Thermal Characteristics

#### **ORDERING INFORMATION**

Order Number	Package	Shipping <sup>†</sup>
NTD5C434NT4G	DPAK (Pb–Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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- NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994. CONTROLLING DIMENSION: INCHES.
  - THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- MENSIONS b3, L3 and Z.
  DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL
- NOT EXCEED 0.006 INCHES PER SIDE 5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY. 6. DATUMS A AND B ARE DETERMINED AT DATUM
- PLANE H

7. OPTIONAL M	OLD FEATURE

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
с	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114	0.114 REF		REF
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN

inches

3 SOURCE DRAIN 4.